Proceedings of the Nineteenth International Symposium on

Quality Electronic Design

ISQED 2018

March 13-14, 2018 Santa Clara, California USA

ISQED 2018 is held with technical sponsorship from the IEEE Circuits and Systems Society (CAS), Electron Devices Society (EDS), and Reliability Society (RS). ISQED 2018 is produced and sponsored by the International Society for Quality Electronic Design www.isqed.com.

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- In the **Table of Contents** (the right-hand column)
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GUIDE TO USING ACROBAT X at a Conference

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Bring a small USB travel mouse; it's faster than touchpad or eraser navigation.

I trust this makes your time at the conference more productive! Paul Wesling 2/2015





EP

Guide to this

Go to Bookmark

Long Bookmarks

Session 2: Liquid (

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Session 3: Tools and Cald

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WELCOME TO ISQED 2018

On behalf of the ISQED 2018 conference and technical committees, we are pleased to welcome you to the 19th International Symposium on Quality Electronic Design.

ISQED 2018 is the premier interdisciplinary and multidisciplinary electronic design conference aimed at bridging the gap among electronic/semiconductor ecosystem members and providing electronic design tools, integrated circuit techniques, semiconductor manufacturing technologies, advanced packaging technologies, and assembly and test methodologies to achieve design quality.

ISQED is held with the technical sponsorship of the IEEE Electron Devices Society, the IEEE Circuits and Systems Society, and the IEEE Reliability Society. ISQED continues to provide and foster a unique opportunity to participants to interact and engage themselves in cutting edge tutorials, presentations, and panel and plenary sessions.

This conference is organized around the theme "Security, IoT, Machine Learning & Electronic Design". We have invited two distinguished keynote speakers who will focus on these topics. Additionally, four embedded tutorials by experts focus on this theme as well.

The two-day technical program with three parallel sessions packs nearly 80 papers highlighting the latest trends in electronic circuit and system design & automation, testing, verification, sensors, security, semiconductor technologies, cyber-physical systems, etc. ISQED 2018 also features a panel discussion, entitled "Deep Learning in System Design" on Tuesday, March 13th.

All of the technical presentations, plenary sessions, panel discussions, tutorials and related events will take place on March 13-14 at the Santa Clara Convention Center in Santa Clara, CA USA. Please refer to the conference booklet and/or ISQED website for program details.

We would like to thank the ISQED 2018 corporate sponsors: Synopsys, Innovotek, and the Silicon Valley Polytechnic Institute for their valuable support of this conference. Welcome to another exciting year of ISQED! It couldn't have happened without your support and participation.

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(continued)

Emerging Process&Device Tech. &Design Issues (EDT)

Shih-Hung Chen, Imec (Chair) Jayita Das, Intel Corp. (Co-Chair)

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Integrated Circuit Design (ICD)

Kurt Schwartz, Texas Instruments (Chair) Jose Pineda, NXP Semiconductors (Co-Chair)

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(continued)

System-level Design and Methodologies (SDM)

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<u>3 Dimensional Integration & Adv. Packaging (TDIP)</u>

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Special Sessions

Jayita Das, Intel Corp. (Chair) Brian Cline, ARM Inc. (Co-Chair)

ISQED 2018 Best Paper Candidates

<u>1B.1</u>

Hybrid-Comp: A Criticality-Aware Compressed Last-Level Cache

Amin Jadidi¹, Mohammad Arjomand², Mahmut T. Kandemir¹, Chita R. Das¹

¹School of Electrical Engineering and Computer Science, Pennsylvania State University, USA ²School of Computer and Electrical Engineering, Georgia Institute of Technology, USA

<u>1C.2</u>

LUPIS : Latch-Up Based Ultra Efficient Processing-in-Memory System Joonseop Sim¹, Mohsen Imani¹, Woojin Choi¹, Yeseong Kim², Tajana Rosing¹ ¹UCSD, ²University of California San Diego

<u>1C.3</u>

Energy efficient neuromorphic processing using spintronic memristive device with dedicated synaptic and neuron terminology Zoha Pajouhi

Intel Corporation

<u>2A.1</u>

Recognition of Regular Layout Structures Yu-Cheng Chiang, Shr-Cheng Tsai and Rung-Bin Lin Yuan Ze University, Taoyuan, Taiwan

<u>2A.2</u>

A Simplified Methodology for Complex Analog Module Layout Generation

Pradeep Kumar Chawda

Texas Instruments Inc.

<u>4A.2.1</u>

A Deep Learning Based Approach for Analog Hardware Implementation of Delayed Feedback Reservoir Computing System

Jialing Li, Kangjun Bai, Lingjia Liu, Yang Yi

Bradley Department of Electrical and Computing Engineering,

Virginia Tech, Blacksburg, Virginia

<u>4A.2.2</u>

An Area and Energy Ecient Design of Domain-Wall Memory-Based Deep Convolutional Neural Networks using Stochastic Computing

Xiaolong Ma¹, Yipeng Zhang1, Geng Yuan¹, Ao Ren1, Zhe Li¹, Jie Han², Jingtong Hu³, Yanzhi Wang¹ ¹Syracuse University, ²university of alberta, ³University of Pittsburgh

<u>4B.2</u>

Parallel implementation of finite state machines for reducing the latency of stochastic computing Cong Ma and David J. Lilja

Department of Electrical and Computer Engineering, University of Minnesota, Twin Cities

<u>5B.1</u>

Securing FPGA-Based Obsolete Component Replacement for Legacy Systems Zhiming Zhang¹, Laurent Njilla², Charles Kamhoua³, Kevin Kwiat², and Qiaoyan Yu¹ ¹University of New Hampshire, ²Cyber Assurance Branch, Air Force Research Laboratory, ³Army Research Laboratory

ISQED 2018 Best Papers

<u>4A.2.1</u>

A Deep Learning Based Approach for Analog Hardware Implementation of Delayed Feedback Reservoir Computing System Jialing Li, Kangjun Bai, Lingjia Liu, Yang Yi Bradley Department of Electrical and Computing Engineering, Virginia Tech, Blacksburg, Virginia

<u>4B.2</u>

Parallel implementation of finite state machines for reducing the latency of stochastic computing Cong Ma and David J. Lilja Department of Electrical and Computer Engineering, University of Minnesota, Twin Cities

* Authors of best papers are honored during the Synopsys sponsored luncheon on Tuesday March 13

GENERAL INFORMATION

ISQED 2018 GENERAL INFORMATION

March 13-14, 2018 Santa Clara Convention Center 5001 Great America Pkwy, Santa Clara, CA 95054

Embedded Tutorials

<u>Chair:</u> Shiyan Hu - Michigan Technological University

<u>Co-Chair:</u> José Pineda de Gyvez - Eindhoven University of Technology

Meeting Rooms 209/210

Tuesday, March 13, 1:35 PM - 2:35 PM

Power-Aware Testing in the Era of IoT

Dr. Patrick Girard LIRMM / CNRS - University of Montpellier / France Tuesday, March 13, 2:35 PM - 3:35 PM

Ambient Energy Harvesting Sensor Platform for Internet of Things: From Circuit to System

Prof. Yongpan Liu Tsinghua University, P.R. China

Prof. Jingtong Hu

University of Pittsburgh

Wednesday, March 14, 1:30 PM - 2:30 PM

Ultra-Low-Power Digital Architectures for the Internet of Things

> **Prof. Davide Rossi** DEI, University of Bologna

Wednesday, March 14, 2:30 PM - 3:30 PM

Managing the ever increasing complexity of Cyber-Physical Systems in High-Tech Industry

Dr. Wouter Leibbrandt

Embedded Systems Innovation, TNO, The Netherlands

KEYNOTE SPEECHES

Tuesday, March 13, 9:00 AM - 10:45 AM Meeting Rooms 209-210

Murphy Was an Optimist: Embracing Asymmetry in Electronics

Kerry Bernstein Microsystems Technology Office Defense Advanced Research Projects Agency (DARPA)

> Tuesday, March 13, 11:50 AM - 12:25 PM Meeting Rooms 209/210

Al Creating New Opportunities for Chip Designers

Dr. Yankin Tanurhan Vice President of Engineering Synopsys

Wednesday, March 14, 9:00 AM - 9:45 AM Meeting Rooms 209/210

Innovation in an Exponential World

Dr. Nate Brese Marketing Fellow, Electronics & Imaging DowDuPont

GENERAL INFORMATION

ISQED LUNCH & AWARDS CEREMONY

Tuesday, March 13, 11:20 AM - 11:50 AM Meeting Rooms 209/210

ISQED Best Paper Awards

Recipients of the ISQED 2018 Best Paper Award will be recognized during the ISQED luncheon on Tuesday. List of best papers is shown in Page 3 of this document.

Luncheon Panel Discussion

Tuesday, March 13, 12:25 PM - 1:25 PM Meeting Rooms 209/210

Machine Learning in Quality Electronic Design

Machine learning is beginning to have an impact on system design and verification business, cutting the cost of designs by allowing tools to suggest solutions to common problems that would take design teams weeks or even months to work through. This reduces cost of designs, and potentially expands the market for such tools, opening the door to new designs and faster turnarounds. In this panel, we will have experts from industry and academia discussing the role of machine learning in designs of today and of a foreseeable future.

TECHNICAL SESSIONS

There are a total of 15 paper sessions held on Tuesday and Wednesday. Technical sessions are held in the format of three parallel tracks in **Meeting Rooms 201, 206 & 207**.

Poster Papers & Mixer

Poster display will take place on Tuesday afternoon 5:15 PM-6:45 PM in the Atrium area outside of the **Meeting Rooms.** Authors will be available to discuss their works and to answer questions. Refreshments will be served.

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ON-SITE REGISTRATION

Tentative time schedule of on-site registration is as follows:

Tuesday, March 13 Wednesday, March 14 8:00 AM - 3:00 PM 8:00 AM -1:00 PM

Registration desk location will be beside the Meeting rooms 209/210.

# **FLOOR PLAN**



# Santa Clara Convention Center 2nd Floor

<u>General Sessions & Tutorials:</u> Meeting Rooms 209/210

Breakout Rooms: Meeting Rooms, 201, 206 and 207

# **PROGRAM AT A GLANCE**

| ISQED 2017 PROGRAM AT A GLANCE |                         |                                                                                                                                        |                                                                                                       |                                                                                    |  |
|--------------------------------|-------------------------|----------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------|--|
| DATE                           | TIME                    |                                                                                                                                        |                                                                                                       |                                                                                    |  |
| TUESDAY 3/13/2018              | 9:00 AM -9:45AM         | KEYNOTE SPEECH<br>(MEETING ROOMS 209/210)                                                                                              |                                                                                                       |                                                                                    |  |
|                                |                         | MURPHY WAS AN OPTIMIST: EMBRACING ASYMMETRY IN ELECTRONICS<br>KERRY BERNSTEIN - DEFENSE ADVANCED RESEARCH PROJECTS AGENCY (DARPA)      |                                                                                                       |                                                                                    |  |
|                                | 9:45 AM - 10:00 AM      |                                                                                                                                        | MORNING BREAK                                                                                         |                                                                                    |  |
|                                |                         | SESSION 1A                                                                                                                             | SESSION 1B                                                                                            | SESSION 1C                                                                         |  |
|                                | 10:00 AM - 11:20 AM     | DESIGN VERIFICATION AND TEST                                                                                                           | SYSTEM-LEVEL DESIGN AND METHODOLOGIES (SDM)                                                           | EMERGING LOGIC AND MEMORY<br>TECHNOLOGIES IN IOT AND NEUROMORPHIC<br>ARCHITECTURES |  |
|                                |                         | MEETING ROOM 201                                                                                                                       | MEETING ROOM 206                                                                                      | MEETING ROOM 207                                                                   |  |
|                                |                         |                                                                                                                                        |                                                                                                       |                                                                                    |  |
|                                | 11:20 AM -11:50 AM      |                                                                                                                                        | ISOED LUNCHEON, KEYNOTE & PANEL<br>MEETING ROOMS 209/210<br>BEST PAPER AWARDS , COMMITTEE RECOGNITION |                                                                                    |  |
|                                | 11:50 AM -12:25 PM      |                                                                                                                                        | LUNCH KEYNOTE                                                                                         |                                                                                    |  |
|                                |                         | AI CRE<br>DR. YANKIN TANURHAN - VICE PRESIDENT EI                                                                                      | ATING NEW OPPORTUNITIES FOR CHIP DESIG<br>NGINEERING, DESIGNWARE PROCESSOR CORES, IP SUBSYSTE         | Bilicon to Boltwere<br>MS, NON-VOLATILE MEMORY, SYNOPSYS                           |  |
|                                | 12:25 PM -1:25 PM       |                                                                                                                                        | PANEL DISCUSSION                                                                                      |                                                                                    |  |
|                                |                         |                                                                                                                                        | DEEP LEARNING IN SYSTEM DESIGN                                                                        |                                                                                    |  |
|                                | 1:25 PM -1:35 PM        |                                                                                                                                        | BREAK                                                                                                 |                                                                                    |  |
|                                | 1.35 PM -2.35 PM        |                                                                                                                                        | EMBEDDED TUTORIAL 1                                                                                   |                                                                                    |  |
|                                | 1007111 2007111         |                                                                                                                                        | POWER-AWARE TESTING IN THE ERA OF IOT                                                                 |                                                                                    |  |
|                                |                         |                                                                                                                                        | MEETING ROOMS 209/210                                                                                 |                                                                                    |  |
|                                | 2:35 PM -3:35 PM        |                                                                                                                                        | EMBEDDED TUTORIAL 2                                                                                   |                                                                                    |  |
|                                |                         | AMBIENT ENERGY HARVESTING                                                                                                              | SENSOR PLATFORM FOR INTERNET OF THIN                                                                  | SS: FROM CIRCUIT TO SYSTEM                                                         |  |
|                                |                         |                                                                                                                                        | MEETING ROOMS 209/210                                                                                 |                                                                                    |  |
|                                | <u>3:35 PM -3:45 PM</u> | SESSION 2A                                                                                                                             | SESSION 2B                                                                                            | SESSION 2C                                                                         |  |
|                                | 3:45 PM -5:25 PM        | AUTOMATED ANALOG AND DIGITAL CIRCUIT<br>OPTIMIZATION                                                                                   | SYSTEM-LEVEL DESIGN AND METHODOLOGIES (SD                                                             | M) POSTER BRIEFS                                                                   |  |
|                                |                         | MEETING ROOM 201                                                                                                                       | MEETING ROOM 206                                                                                      | MEETING ROOM 207                                                                   |  |
|                                | 5:25 PM -6:45 PM        |                                                                                                                                        | HALLWAY OUTSIDE MEETINGS ROOMS                                                                        |                                                                                    |  |
|                                |                         |                                                                                                                                        |                                                                                                       |                                                                                    |  |
| WEDNESDAY 3/14/2018            | 9:00 AM -9:45 AM        |                                                                                                                                        | KEYNOTE SPEECH                                                                                        |                                                                                    |  |
|                                | 21007111 21137111       |                                                                                                                                        | (MEETING ROOMS 209/210)                                                                               |                                                                                    |  |
|                                | 0:45 AM -10:00 AM       |                                                                                                                                        | NATE BRESE - ELECTRONICS & IMAGING - DOWDUPONT                                                        |                                                                                    |  |
|                                | 9.45 AM 10.00 AM        | SESSION 3A                                                                                                                             | MORNING BREAK<br>SESSION 3B                                                                           | SESSION 3C                                                                         |  |
|                                | 10:00 AM -11:20 AM      | DESIGN VERIFICATION AND TEST                                                                                                           | HIGH PERFORMANCE / LOW POWER LOGIC DESIGN                                                             | IOT & SMART SENSORS                                                                |  |
|                                | 11.20 AM - 11.40 AM     | MEETING ROOM 201                                                                                                                       | MEETING ROOM 206                                                                                      | MEETING ROOM 207                                                                   |  |
|                                | 11.20 AM 11.40 AM       | SESSION 4A (4A.1 & 4A.2                                                                                                                | SESSION 4B                                                                                            | SESSION 4C                                                                         |  |
|                                | 11:40 AM -1:00 PM       | MACHINE LEARNING ON CONVENTIONAL AND<br>EMERGING PLATFORMS<br>MEETING ROOM 201                                                         | MEETING ROOM 206                                                                                      | MEETING ROOM 207                                                                   |  |
|                                | 1:00 PM -1:30 PM        |                                                                                                                                        | LUNCH BREAK                                                                                           |                                                                                    |  |
|                                | 1:30 PM -2:30 PM        | EMBEDDED TUTORIAL 3<br>ULTRA-LOW-POWER DIGITAL ARCHITECTURES FOR THE INTERNET OF THINGS<br>MEETING ROOMS 209/210                       |                                                                                                       |                                                                                    |  |
|                                | 2:30 PM -3:30 PM        | EMBEDDED TUTORIAL4<br>MANAGING THE EVER INCREASING COMPLEXITY OF CYBER-PHYSICAL SYSTEMS IN HIGH-TECH INDUSTRY<br>MEETING ROOMS 209/210 |                                                                                                       |                                                                                    |  |
|                                | 3:30 PM -3:40 PM        |                                                                                                                                        | AFTERNOON BREAK                                                                                       |                                                                                    |  |
|                                | 3:40 PM -5:00 PM        | SESSION 5A<br>ENERGY EFFICIENT LOGIC DESIGN USING SCALED<br>TECHNOLOGIES                                                               | SESSION 5B<br>HARDWARE SECURITY: PUF, OBFUSCATION, AND<br>TROJAN DETECTION                            | SESSION 5C<br>DEMYSTIFYING SELF-DRIVING CARS                                       |  |
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# **ISQED Keynote 1P.1**

# Tuesday March 13

*9:00 AM - 9:45 AM* Meeting Rooms 209/210

# **Murphy Was an Optimist: Embracing Asymmetry in Electronics**



### Kerry Bernstein Defense Advanced Research Projects Agency (DARPA)

The high performance digital microelectronic component is designed to do one thing – that is to faithfully execute its instruction set architecture. The resulting hardware embodiment, however, forces structure into materials that resist order. These structures immediately begin reverting to their lowest energy state and highest disorder. Semiconductor wear-out and aging are evidence of this entropy. Countering these effects is expensive, and contributes nothing to transaction throughput or energy efficiency. Against this backdrop, selected emerging concepts in device physics, process, design, architecture, reliability and hardware security may collectively embrace entropy, and use asymmetry in our favor. This talk will provide an overview of concepts that connect low level device physics to high level architecture in a way that leverages asymmetry in our favor. Given that current devices are confronting not just atomistic but now quantum-mechanical limitations to scaling, the need is greater than ever.

#### **About Kerry Bernstein**

Kerry Bernstein is a program manager in the Microsystems Technology Office at the Defense Advanced Research Projects Agency (DARPA). His interests are in the area of hardware security and emerging high performance post-CMOS device technologies. Mr. Bernstein formerly spent 33 years at the IBM T.J. Watson Research Center and IBM Microelectronics, working in the areas of leading edge, high performance/low-power computing devices and circuits, and 3D Integration. He attributes any successes realized to be due in large part to being surrounded by wonderful people throughout his entire career. Mr. Bernstein received his B.S. (1978) in Electrical Engineering from Washington University in St. Louis, Missouri, and continued graduate work at the University of Vermont. He has co-authored four (4) textbooks, holds 155 patents, and is a Fellow of the Institute of Electrical and Electronics Engineers (IEEE).

# Tuesday March 13

*11:50 AM - 12:25 PM* Meeting Rooms 209/210

# **AI Creating New Opportunities for Chip Designers**



Dr. Yankin Tanurhan Synopsys

Summary: Rapid advances in artificial intelligence (AI) and machine learning are creating the next wave of opportunities for SoC designers. From facial recognition to surveillance monitoring to autonomous driving, AI is becoming must-have technology for an expanding number of tech applications. Neural networks, modeled after the human brain, have significantly improved developers' ability to implement machine learning hardware and software in edge devices, particularly for object detection and embedded vision applications. This keynote presentation provides an industry perspective on AI trends and emerging uses.

#### About Yankin Tanurhan

Dr. Yankin Tanurhan is Vice President Engineering, DesignWare Processor Cores, IP Subsystems, Non-Volatile Memory at Synopsys leading low power and high-performance ARC and EV Embedded Processor developments targeted from Mobile, IoT, Embedded Vision, AI/ML, Digital Home, Automotive/Industrial, Security to Storage markets. His portfolio additionally includes ASIP tool development with products like ASIP Designer and Programmer, IP Subsystems products like Sensor Fusion, Audio, Vision and Security Subsystems and CMOS based Non-Volatile Memory IP development. Dr. Tanurhan has authored 100+ papers in refereed publications. He holds a B.S. and M.S. in Electrical and Computer Engineering from Rheinisch Westfaellische Technische Hochschule (RWTH) in Aachen, Germany and a Dr. Ing. degree summa cum laude in Electrical Engineering from the University of Karlsruhe (TH) in Karlsruhe, Germany.

# **Panel Discussion**

# Tuesday March 13

*12:25 PM – 1:25 PM* Meeting Rooms 209/210

# **Machine Learning in Quality Electronic Design**

**Summary**: Machine learning is beginning to have an impact on system design and verification business, cutting the cost of designs by allowing tools to suggest solutions to common problems that would take design teams weeks or even months to work through. This reduces cost of designs, and potentially expands the market for such tools, opening the door to new designs and faster turnarounds. In this panel, we will have experts from industry and academia discussing the role of machine learning in designs of today and of a foreseeable future.

Moderator: Vinod Viswanath - Director of Research and Development, Real Intent

Panelists: Dr. Chris Rowen - CEO, Cognite Ventures Dr. Drew Wingard - CEO, Sonics Inc. Prof. Paul Franzon - Cirrus Logic Distinguished Professor of ECE, NCSU Dr. Yankin Tanurhan - VP Engineering, Synopsys

# Wednesday March 14

*9:00 AM - 9:45 AM* Meeting Rooms 209/210

# **Innovation in an Exponential World**



Nate Brese DowDuPont

The interplay of design objectives, regulatory disruptions, performance criteria and materials innovations have enabled electronic devices to evolve in accord with roadmaps, "laws" and correlations over the past half century. New opportunities to lower cost and improve performance have led designers into the third dimension where packaging offers miniaturization and efficiency gains. As we approach the tipping point for interconnected devices of all sorts, materials and design ingenuity are in high demand. This talk will focus on key market drivers and challenges facing our industry. We will discuss recent materials and design innovations required by emerging applications as well as the roadmaps guiding us into the future.

#### **About Nate Brese**

Nate Brese is a Marketing Fellow in Strategic Marketing and Business Development within DowDuPont Electronics and Imaging. He currently leads acquisition and alliance strategy and has business development activities in a variety of highgrowth market segments such as automotive, medical, and high-speed communication. Dr. Brese earned his B.A. in the Integrated Sciences Program at Northwestern Univ. and his Ph. D. in Solid State Chemistry from Arizona State Univ. He conducted postdoctoral research at the Max Planck Institut für Festkörperforschung in Stuttgart, Germany, and at Cornell Univ. He later completed the two-year Wharton Management Certification Program at Univ. Pennsylvania. As a research scientist and marketing professional at OSRAM Sylvania, Rohm and Haas, and Dow Electronic Materials, Nate has been instrumental in launching new products, creating business plans, assessing acquisition targets, and developing business opportunities in numerous areas, including phosphors, advanced packaging, industrial finishing, military optics, LEDs, and optical communication. He organized a Gordon Conference on Solid State Chemistry and a Materials Research Society Symposium on Solid State Chemistry. He is a member of the ACS, ECS, IEEE, MRS, and the Technical Committee of iNEMI. Nate is a co-inventor on over 20 US patents and co-author of 40 scientific papers.

# Tuesday March 13

*1:35 PM - 2:35 PM* Meeting Rooms 209/210

# Power-Aware Testing in the Era of IoT



### Dr. Patrick Girard LIRMM / CNRS - University of Montpellier / France

Summary: Managing power consumption of circuits and systems is one of the most important challenges for the semiconductor industry in the era of IoT. Power management techniques are used today to control the power dissipation during functional operation. Since the application of these techniques has profound implications on manufacturing test, poweraware testing has become indispensable for low-power LSIs and IoT devices. This tutorial provides a comprehensive and practical coverage of power-aware testing. Its first part gives the background and discusses power issues during test. The second part provides comprehensive information on structural and algorithmic solutions for alleviating test-powerrelated problems. The third part outlines low- power design techniques and shows how low-power devices can be tested safely without affecting yield and reliability.

#### **About Patrick Girard**

Patrick GIRARD received a M.Sc. degree in Electrical Engineering and a Ph.D. degree in Microelectronics from the University of Montpellier, France, in 1988 and 1992 respectively. He is currently Research Director at CNRS (French National Center for Scientific Research) and works in the Microelectronics Department of the Laboratory of Informatics, Robotics and Microelectronics of Montpellier (LIRMM) - France. From 2010 to 2014, he was head of this Microelectronics Department. He is co-Director of the International Associated Laboratory « LAFISI » (French-Italian Research Laboratory on Hardware-Software Integrated Systems) created in 2013 by the CNRS and the University of Montpellier with the Politecnico di Torino, Italy. His research interests include all aspects of digital testing and memory testing, with emphasis on critical constraints such as timing and power. Reliability and fault tolerance are also part of his research activities. He has served on numerous conference committees and is the founder and Editor-in-Chief of the ASP Journal of Low Power Electronics (JOLPE). He is also an Associate Editor of the IEEE Transactions on Computers, IEEE Transactions on CAD and the Journal of Electronic Testing – Theory and Applications (JETTA - Springer). He has supervised 37 PhD dissertations and has published 7 books or book chapters, 65 journal papers, and more than 230 conference and symposium papers on these fields. Patrick Girard is a Fellow of IEEE.

# **Embedded Tutorial 2**

# Tuesday March 13

2:35 PM -3:35 PM Meeting Rooms 209/210

# Ambient Energy Harvesting Sensor Platform for Internet of Things: From Circuit to System



Prof. Yongpan Liu Tsinghua University, P.R. China

Summary: Internet of things are regarded as a very promising market in the next decade. However, batteries have become as a critical obstacle due to their limited operating time and frequent maintenance. Energy harvesting techniques are proposed to relieve those problems and self-powered sensor nodes are attracting more and more attentions. A typical self-powered sensor node consists of power supply and computation system, and it collects energy from ambient power sources, such as solar, vibration, temperature difference and RF energy. Several major design challenges exist in the present self-powered sensor nodes: 1) Limited output power: The typical generated power ranges from several mW to hundreds of uW, leading to a gap of several orders of magnitude between the harvested energy and the consumption of mainstream low power chips. 2) Frequent power failures: Lots of power failures occur frequently in self-powered systems, requiring efficient operations in an energy intermittent mode. 3) Hard to predict: The power profiles are determined by the ambient factors and hard to be predicted. This tutorial will provide several state-of-the-art techniques from circuit levels to system levels to handle above challenges, including nonvolatile processor design, architecture exploration, software and system optimization techniques for energy harvesting sensor platform. Finally, we demonstrate a smart ultraviolet monitoring system using CNN-based pattern recognition on the platform.

#### About Yongpan Liu

Dr. Yongpan Liu received his B.S., M.S. and Ph.D. degrees from Electronic Engineering Department, Tsinghua University in 1999, 2002 and 2007. He was a visiting scholar at Pennsylvania State University in 2014. He is a key member of Tsinghua-Rohm Research Center and Research Center of Future ICs. He is now an associate professor in Dept. of Electronic Engineering Tsinghua University. His main research interests include nonvolatile computation, low power VLSI design, emerging circuits and systems and design automation. He has published over 100 peer-reviewed conference and journal papers and led over 6 chip design projects for sensing applications, including the first nonvolatile processor (THU1010N). His research is supported by NSFC, 863, 973 Program and Industry Companies such as Huawei, Rohm, Intel and so on. These projects lead to the first nonvolatile processor THU1010N and a series of advanced versions. The line of processors has been adopted for the research of self-powered sensing platforms in 7 universities His work has received Under 40 Young Innovators Award DAC 2017, Micro Top Pick 2016, Best Paper Award in ASPDAC2017, HPCA 2015, 2 Design Contest Awards in ISLPED 2012 and 2013, and 2 Best Paper Nominations in ASPDAC 2013 and 2016. He holds 7 authorized Chinese patents and 1 authorized U.S. patent.

# Wednesday March 14

*1:30 PM - 2:30 PM* Meeting Rooms 209/210

# **Ultra-Low-Power Digital Architectures for the Internet of Things**



Prof. Prof. Davide Rossi DEI, University of Bologna

Summary: A growing number of Internet of Things (IoT) applications require flexible processing of data streams generated by multiple sensors, such as accelerometers, low-resolution cameras, microphone arrays, and vital signs monitors. These applications share the need for high performance and extreme energy efficiency in a power envelope of a few milliWatts, while keeping the flexibility of software programmable architectures to deal to the vast variety of near-sensor data analytics algorithms. This tutorial presents an overview of the emerging architectures implementing the digital processing and control platforms for Internet of things applications. It will provide a review of the state of the art Ultra-Low-Power (ULP) micro-controllers architectures, highlighting main challenges and perspectives, and introducing the potential of exploiting parallel near-threshold computing in this field currently dominated by single-issue processors.

#### **About Davide Rossi**

David Rossi received the PhD from the University of Bologna, Italy, in 2012. He has been a post doc researcher in the Department of Electrical, Electronic and Information Engineering "Guglielmo Marconi" at the University of Bologna since 2015, where he currently holds an assistant professor position. His research interests focus on energy efficient digital architectures in the domain of heterogeneous and reconfigurable multi and many-core systems on a chip. This includes architectures, design implementation strategies, and runtime support to address performance, energy efficiency, and reliability issues of both high end embedded platforms and ultra-low-power computing platforms targeting the IoT domain. In this fields he has published more than 60 paper in international peer-reviewed conferences and journals.

# Wednesday March 14

2:30 PM - 3:30 PM Meeting Rooms 209/210

# Managing the ever increasing complexity of Cyber-Physical Systems in High-Tech Industry



### Dr. Wouter Leibbrandt Embedded Systems Innovation, TNO, The Netherlands

Summary: The complexity of advanced cyber-physical systems is ever increasing, making it progressively more difficult to design in a proper and efficient way for system properties such as e.g. performance, reliability, upgradability, safety and security. High tech cyber-physical systems as diverse as industrial printers, cars, medical imaging and IC-manufacturing equipment often contain hundreds of processing elements, tens of millions of lines-of-code, with thousands of interfaces. The same holds for distributed systems like IoT. Architects and designers are rapidly losing grip and overview. A more fundamental basis of embedded systems engineering is being developed to address these issues and starting to be applied. This Model-Based Systems Engineering (MBSE) approach aims at reasoning about non-functional, system, properties such as performance from the highest system architecture level down to the engineering level for individual components. Objective is to assure that in the end system requirements and stakeholder needs are fulfilled, and that components and systems can be tested and validated in a meaningful way. In this tutorial we introduce some of the key principles, such as executable models and domain specific languages, and concerns of MBSE, and present examples from the car entertainment and industrial printing domains. Furthermore, we discuss the current developments which will further increase complexity of cyber-physical systems in the near future, such as autonomous systems and adaptive and learning systems.

#### **About Wouter Leibbrandt**

Wouter Leibbrandt is general manager of the Embedded Systems Innovation department in TNO (TNO-ESI). TNO-ESI focusses on the development of new methods and techniques for design and engineering of increasingly complex hightech (embedded) systems. It does so in strong partnership and close collaboration with leading high-tech companies such as ASML, Philips, Thales, NXP, Océ, Thermo-Fisher and DAF as well as with leading academic groups in the Netherlands and across Europe. Until early 2016 Wouter was with NXP Semiconductors for 10 years, where he managed the Advanced Applications Lab, investigating new application concepts around future advanced silicon products, driving secure connections for a smarter world. The recurring theme here is that everything is getting connected with everything (IoT). Before joining NXP, he was with Philips Research labs for 14 years, managing a variety of projects and departments. From 2004 to 2006 he lived and worked in China, founding and managing part of the Philips Research labs in Shanghai. Wouter holds a PhD in physics from Utrecht University.

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